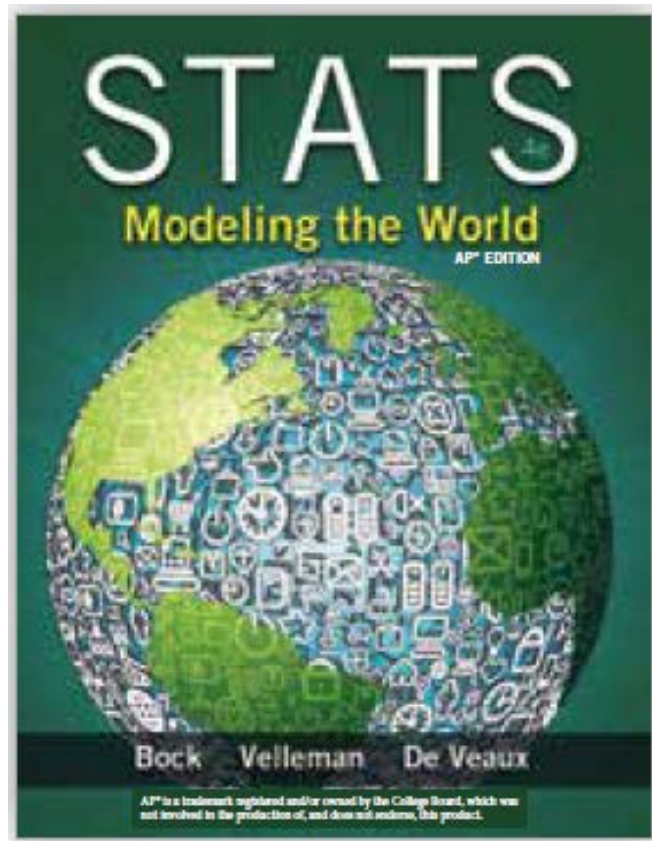


**SAVVAS**

A Correlation of

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**Modeling the World**  
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to the

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Advanced Placement Statistics	Stats: Modeling the World AP Edition, ©2015
<b>I. Exploring Data: Describing patterns and departures from patterns</b>	
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